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(12) **United States Design Patent**
Wrisley et al.

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(54) **HOUSING FOR TEST AND MEASUREMENT INSTRUMENTS**

DESCRIPTION

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(**) Term: **14 Years**

(21) Appl. No.: **29/204,635**

(22) Filed: **Apr. 30, 2004**

(51) **LOC (7) Cl.** **10-04**

(52) **U.S. Cl.** **D10/76**

(58) **Field of Search** D10/76, 78, 80;
324/102, 112, 121 R; 340/734, 747, 798;
354/487

The ornamental design disclosed in this application is for a housing for test and measurement instruments, such as oscilloscopes, logic analyzers, waveform generators, and the like. The housing has a substantially rectangular front face with a substantially rectangular opening disposed in a portion thereof, side surfaces having a curved top edges, and a top surface having curved surfaces adjacent to the curved top edges of the side surfaces that transition to a substantially flat surface extending from the front face to the rear surface having a recess formed therein for receiving a recessed handle.

FIG. 1 is a perspective view of a housing for test and measurement instruments;

FIG. 2 is a front elevation view of the housing for test and measurement instruments;

FIG. 3 is a left side elevation view of the housing for test and measurement instruments;

FIG. 4 is a right side elevation view of the housing for test and measurement instruments;

FIG. 5 is a top plan view of the housing for test and measurement instruments;

FIG. 6 is a bottom plan view of the housing for test and measurement instruments; and,

FIG. 7 is a rear elevation view of the housing for test and measurement instruments.

(56) **References Cited**

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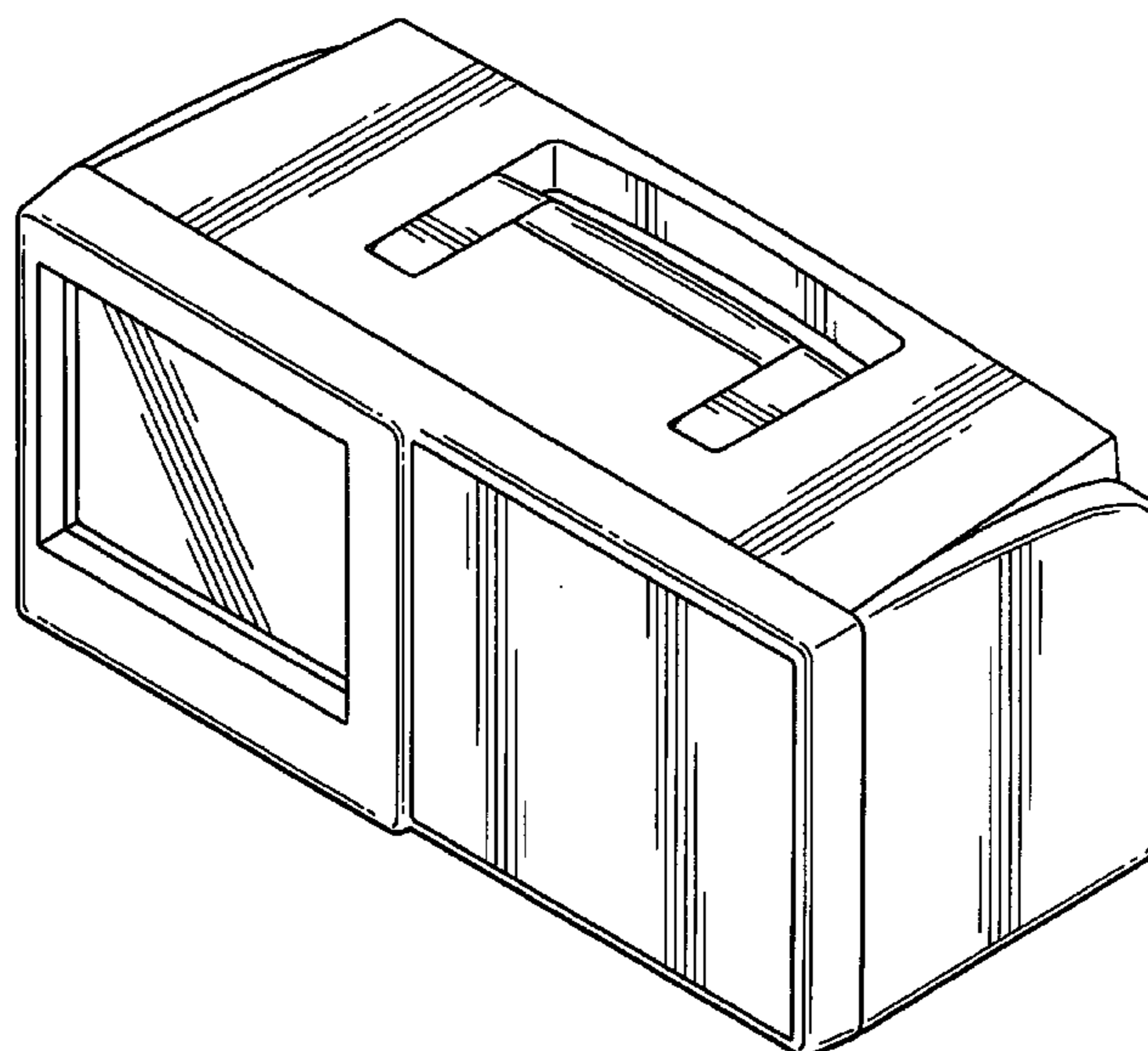
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(57) **CLAIM**

The ornamental design of a housing for test and measurement instruments, as shown and described.

1 Claim, 6 Drawing Sheets



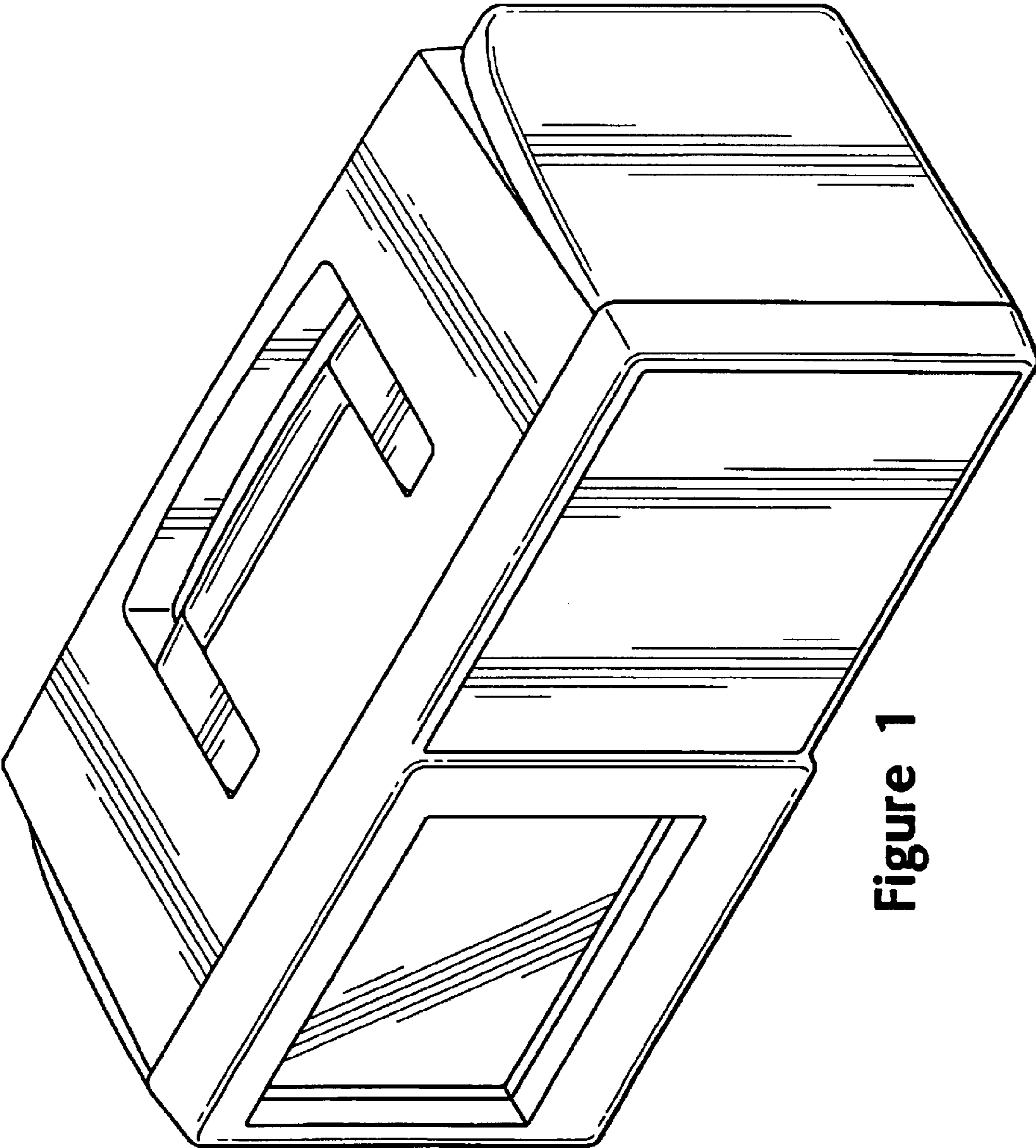


Figure 1

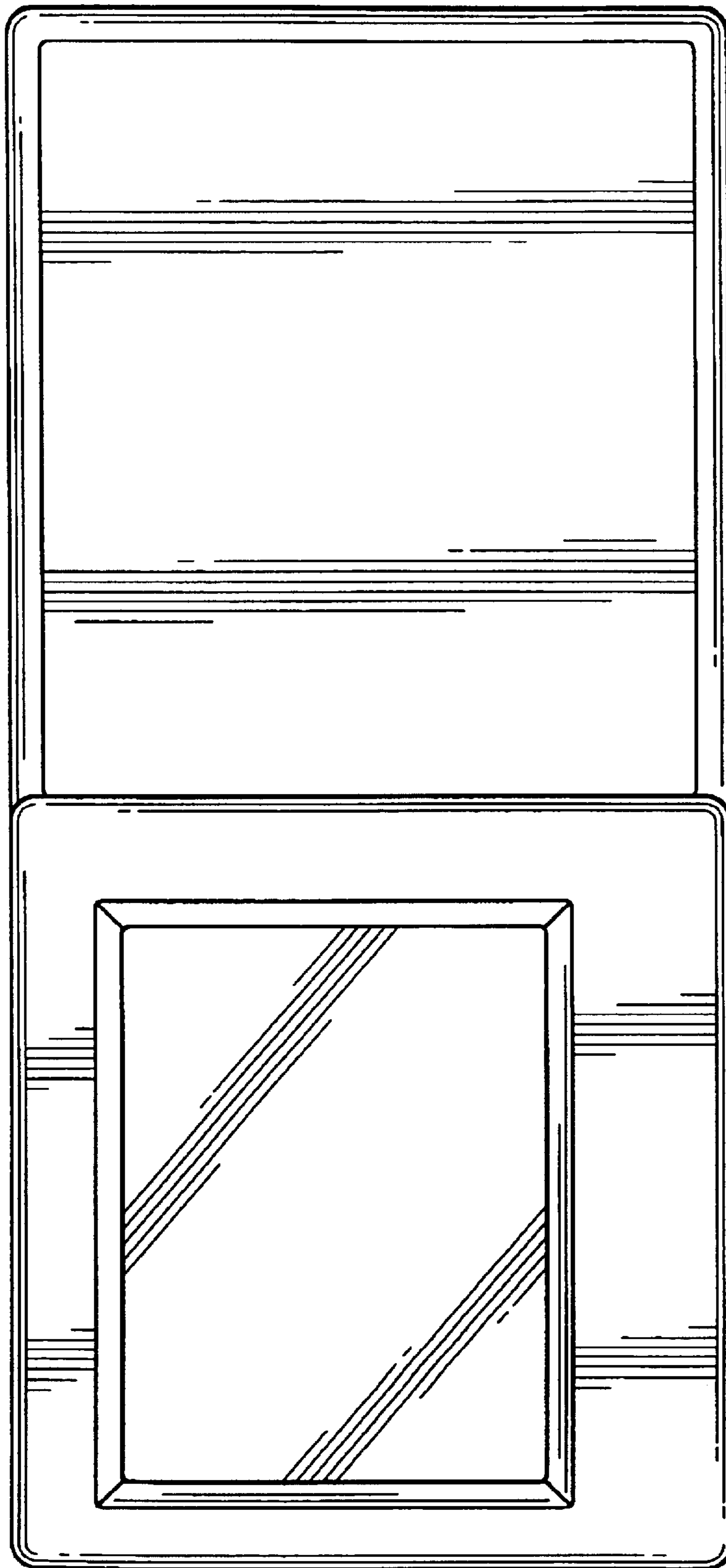


Figure 2

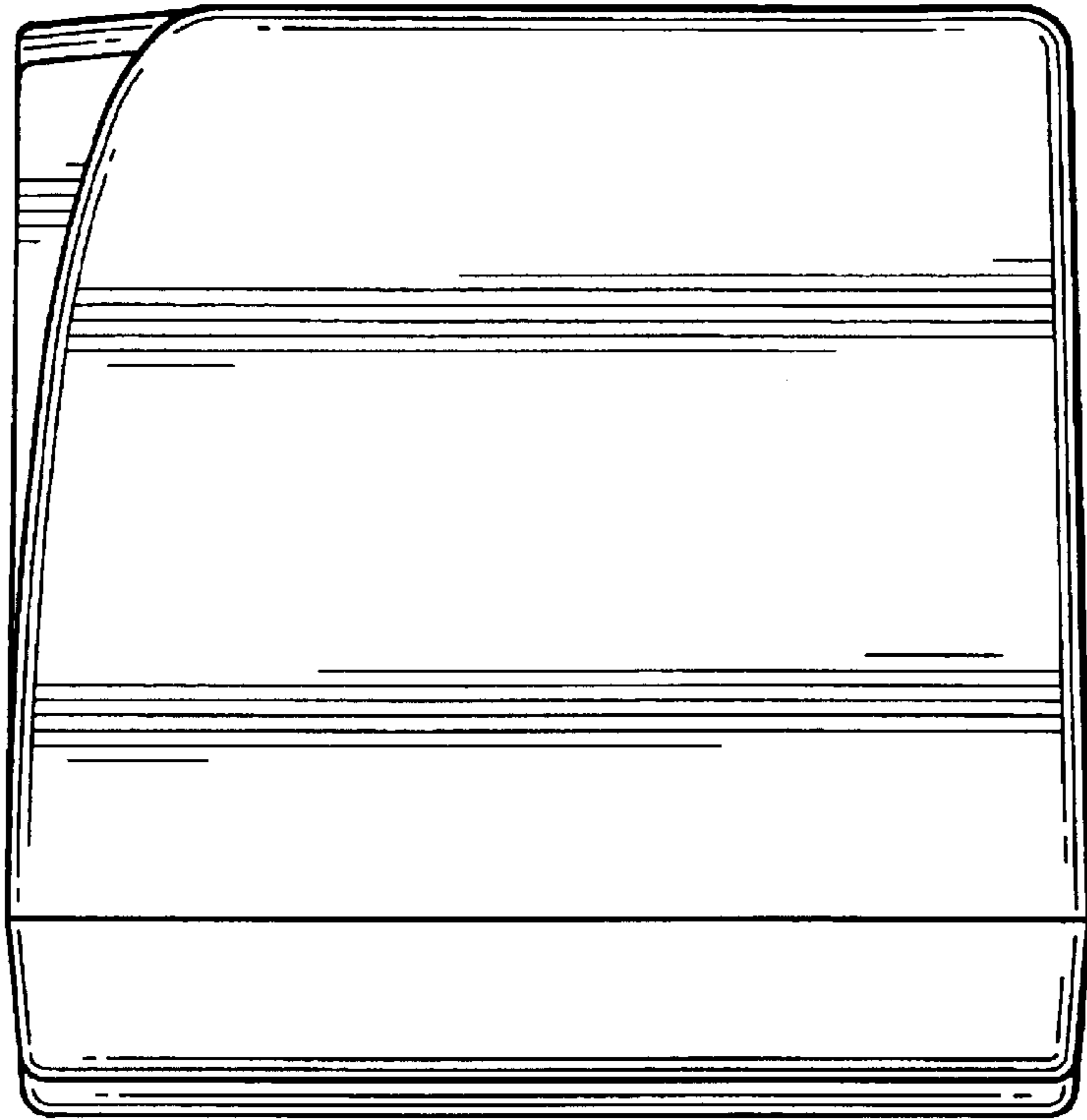


Figure 4

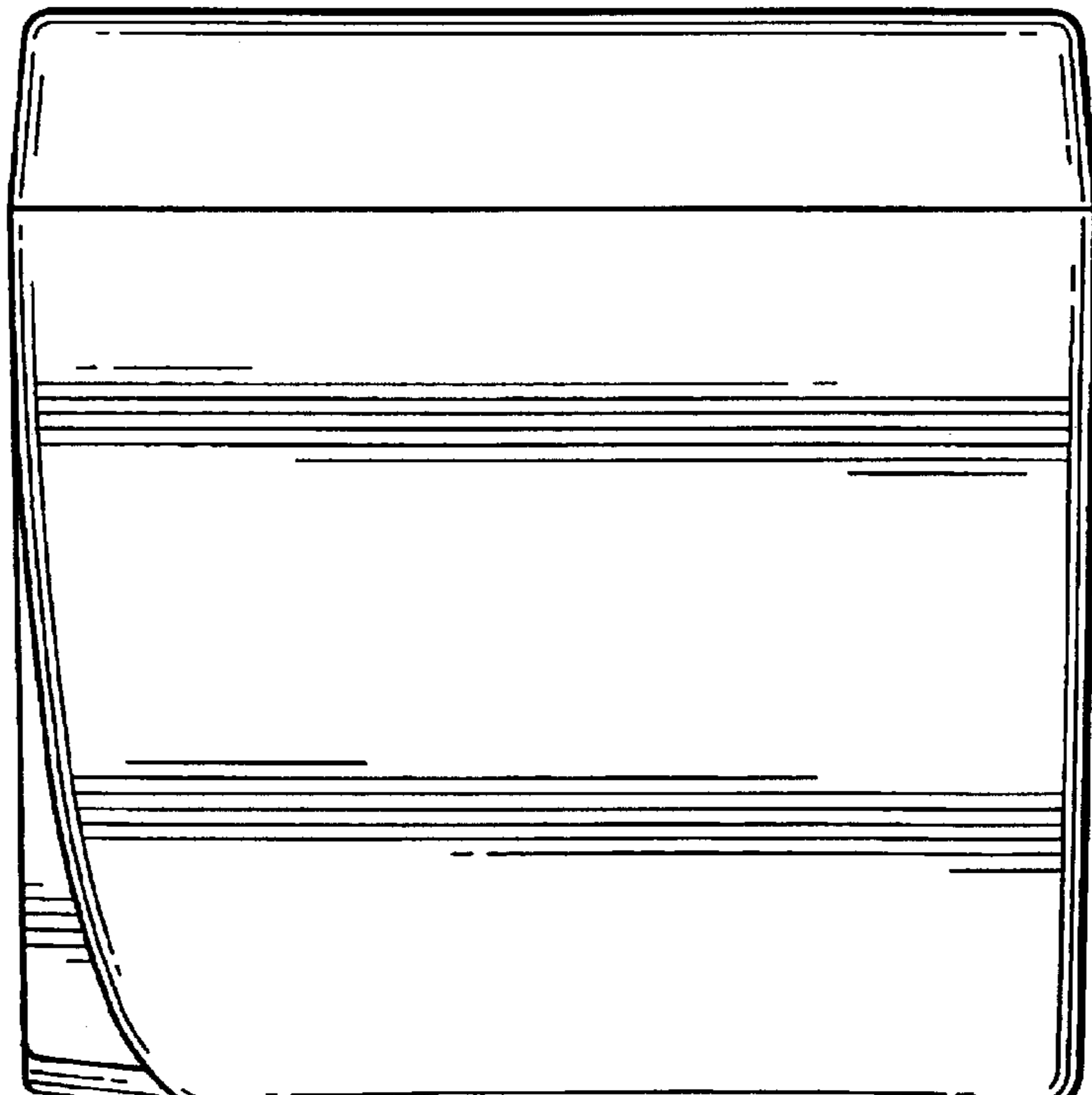


Figure 3

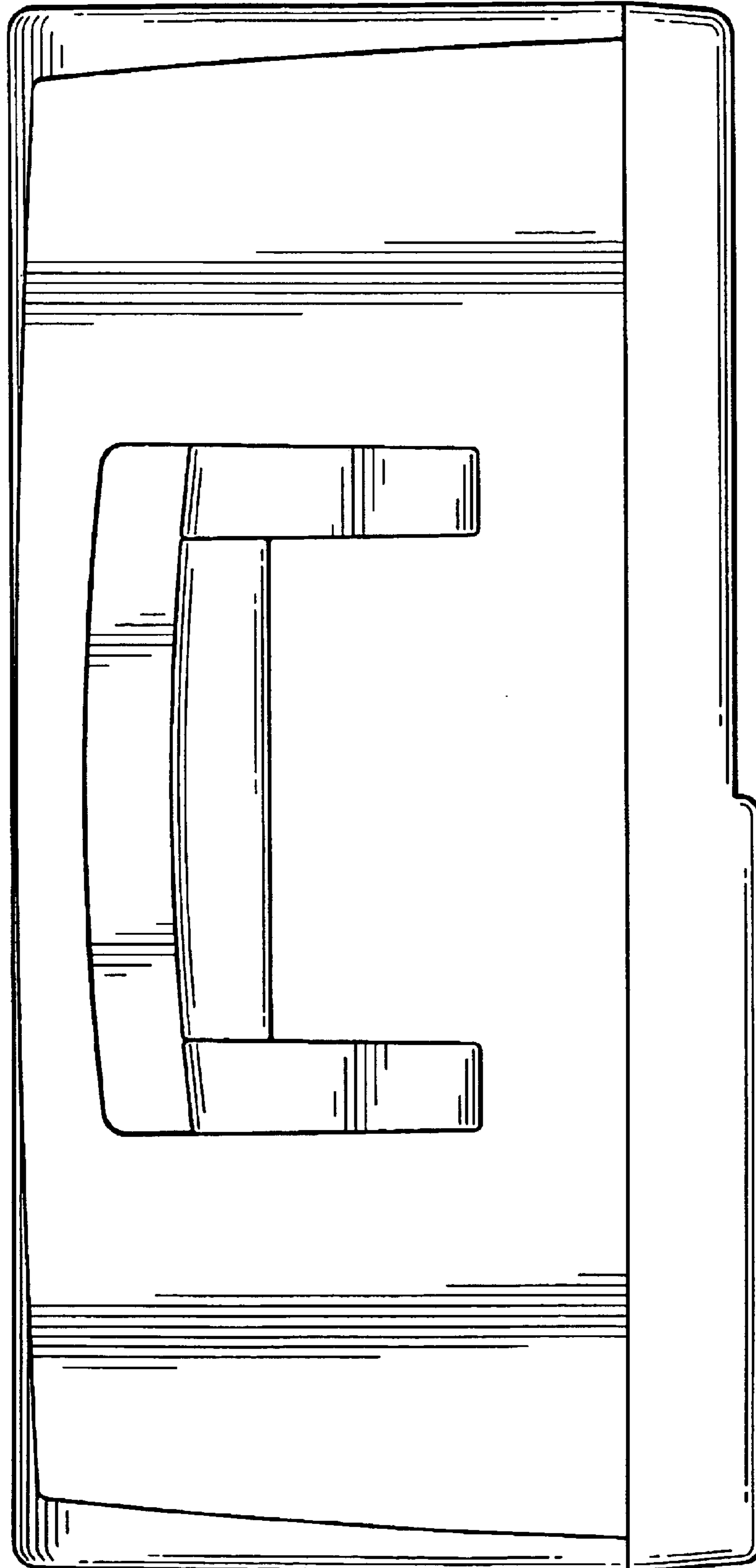


Figure 5

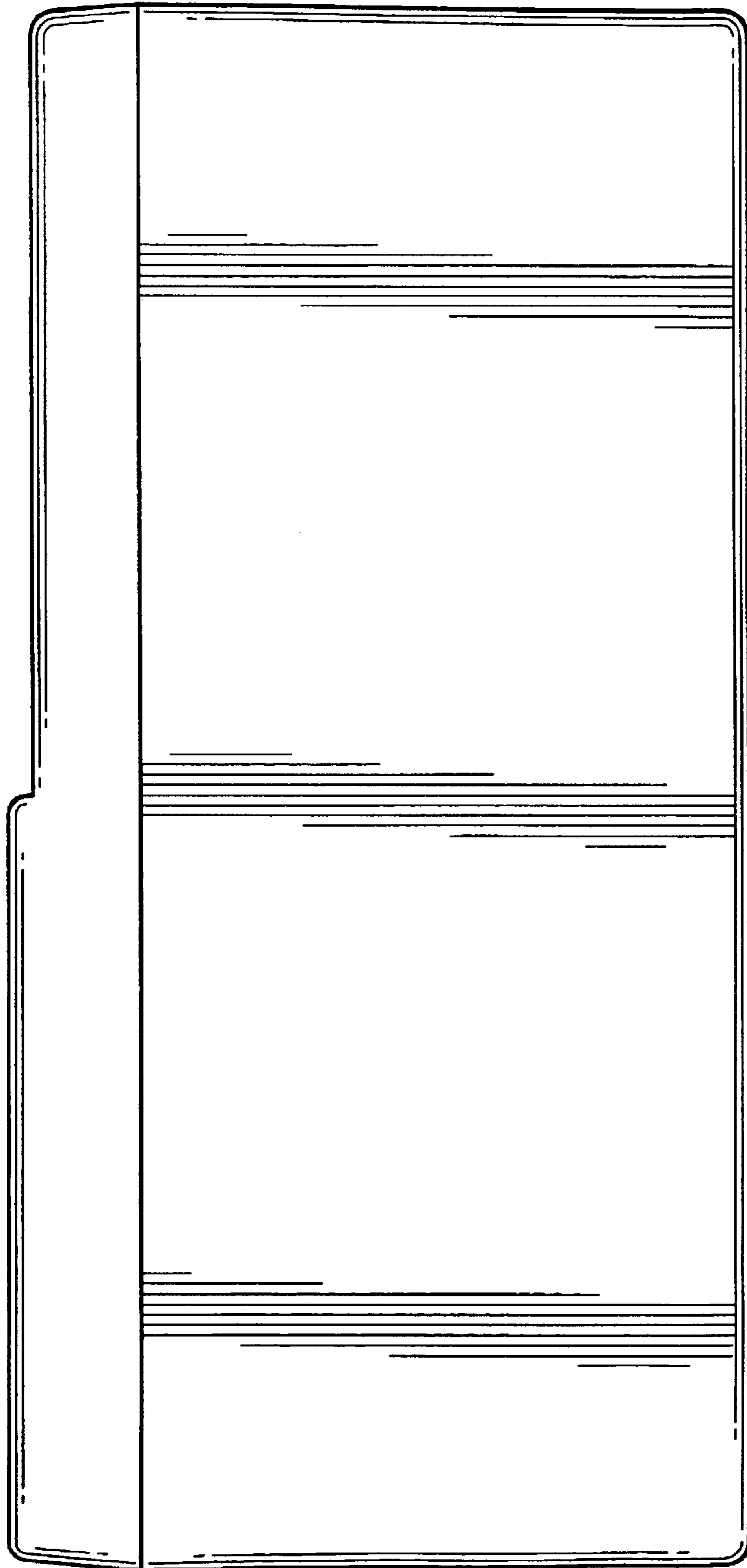


Figure 6

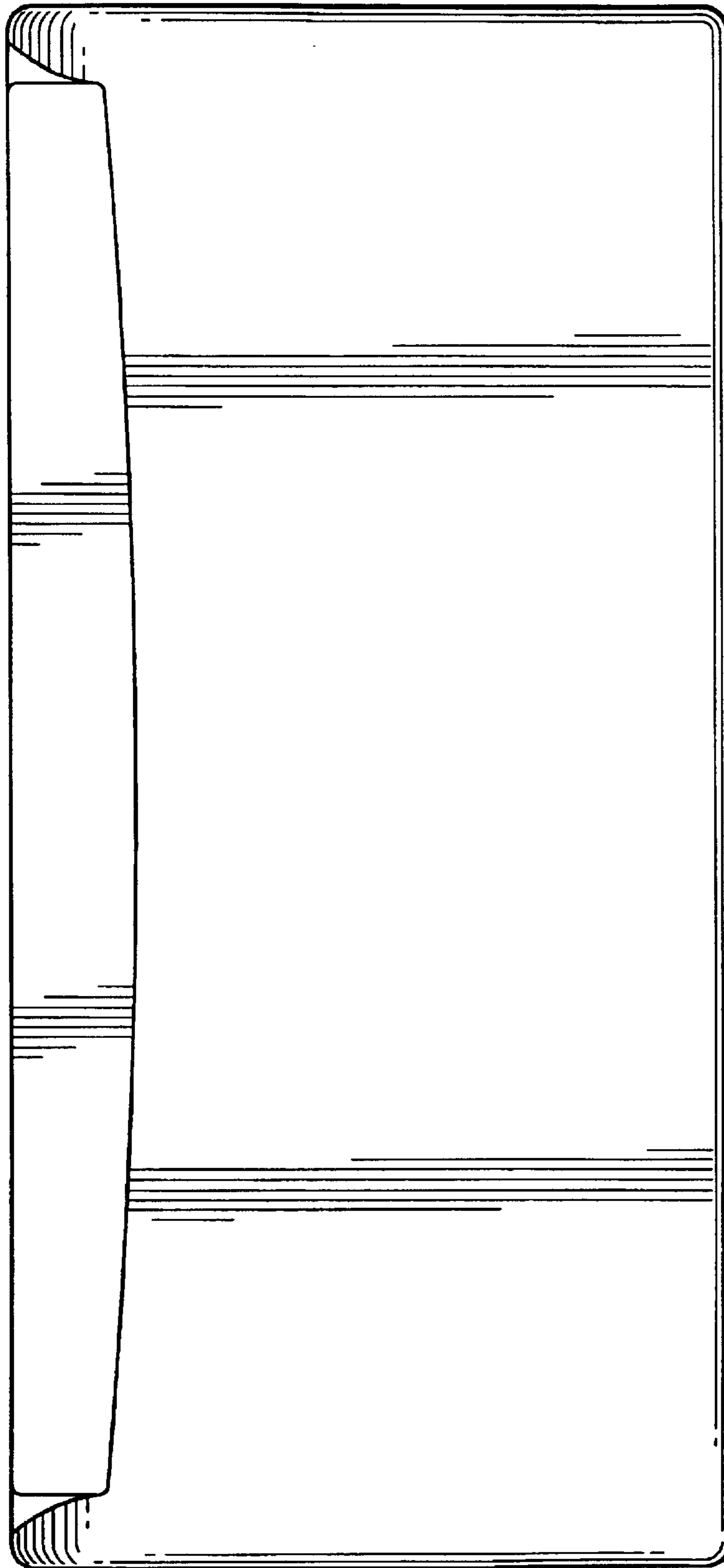


Figure 7